

MJ P-Channel Enhancement Mode Power MOSFET

Description

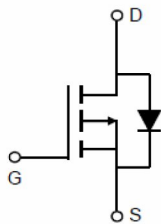
The MJ20P45Q uses advanced trench technology and design to provide excellent $R_{DS(ON)}$ with low gate charge. It can be used in a wide variety of applications.

General Features

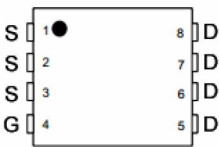
- ◆ $V_{DS}=-20V, I_D=-45A$
 $R_{DS(ON)}<7m\Omega @ V_{GS}=-4.5V$
 $R_{DS(ON)}<9m\Omega @ V_{GS}=-2.5V$
 $R_{DS(ON)}<12m\Omega @ V_{GS}=-1.8V$
- ◆ High density cell design for ultra low R_{dson}
- ◆ Fully characterized avalanche voltage and current
- ◆ Good stability and uniformity with high E_{AS}
- ◆ Excellent package for good heat dissipation

Application

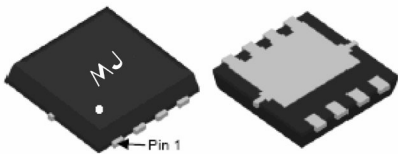
- ◆ Load switch
- ◆ Battery protection



Schematic diagram



Pin Assignment



DFN 3.3x3.3 top view

Package Marking and Ordering Information

Device Marking	Device	Device Package	Reel Size	Tape width	Quantity
MJ20P45Q	MJ20P45Q	DFN 3.3x3.3-8L	-	-	-

Absolute Maximum Ratings (T_c =25 °C unless otherwise noted)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	V_{DS}	-20	V
Gate-Source Voltage	V_{GS}	±10	V
Drain Current-Continuous	I_D	-45	A
Drain Current-Continuous(T _c =100°C)	$I_{D(100^{\circ}C)}$	-35	A
Pulsed Drain Current	I_{DM}	-200	A
Maximum Power Dissipation	P_D	80	W
Single pulse avalanche energy ^(Note 5)	E_{AS}	180	mJ
Derating factor		0.64	W/°C
Operating Junction and Storage Temperature Range	T_J, T_{STG}	-55 To 150	°C

Thermal Characteristic

Thermal Resistance,Junction-to-Case ^(Note 2)	$R_{\theta JA}$	1.6	°C/W
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Electrical Characteristics (T_A =25°Cunless otherwise noted)

Parameter	Symbol	Condition	Min	Typ	Max	Unit
Off Characteristics						
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} =0V I _D =-250μA	-20	-	-	V
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} =-16V,V _{GS} =0V	-	-	1	μA
Gate-Body Leakage Current	I _{GSS}	V _{DS} =±10V,V _{DS} =0V	-	-	±100	nA
On Characteristics <small>(Note 3)</small>						
Gate Threshold Voltage	V _{GS(th)}	V _{DS} =V _{GS} ,I _D =-250μA	-0.4	-0.6	-1.0	V
Drain-Source On-State Resistance	R _{DS(ON)}	V _{GS} =-4.5V, I _D =-20A	-	5.8	7	mΩ
		V _{GS} =-2.5V, I _D =-20A	-	7.2	9	mΩ
		V _{GS} =-1.8V, I _D =-20A	-	9	12	mΩ
Forward Transconductance	g _{FS}	V _{DS} =-5V,I _D =-20A	80	-	-	S
Dynamic Characteristics <small>(Note 4)</small>						
Input Capacitance	C _{iss}	V _{DS} =-10V,V _{GS} =0V, F=1.0MHz	-	3500	-	PF
Output Capacitance	C _{oss}		-	577	-	PF
Reverse Transfer Capacitance	C _{rss}		-	445	-	PF
Switching Characteristics <small>(Note 4)</small>						
Turn-on Delay Time	t _{d(on)}	V _{DD} =-10V, R _{GEN} =3Ω V _{GS} =-4.5V,R _L =0.5Ω	-	18	-	nS
Turn-on Rise Time	t _r		-	42	-	nS
Turn-Off Delay Time	t _{d(off)}		-	85	-	nS
Turn-Off Fall Time	t _f		-	23	-	nS
Total Gate Charge	Q _g	V _{DS} =-10V,I _D =-20A, V _{GS} =-4.5V	-	55	-	nC
Gate-Source Charge	Q _{gs}		-	10	-	nC
Gate-Drain Charge	Q _{gd}		-	15	-	nC
Drain-Source Diode Characteristics						
Diode Forward Voltage <small>(Note 3)</small>	V _{SD}	V _{GS} =0V,I _S =-20A	-	-	1.2	V
Diode Forward Current <small>(Note 2)</small>	I _S		-	-	-45	A
Reverse Recovery Time	t _{rr}	T _J =25°C, I _F =-10A di/dt=100A/μs <small>(Note 2)</small>	-	47	-	nS
Reverse Recovery Charge	Q _{rr}		-	53	-	nC
Forward Turn-On Time	ton	Intrinsic turn-on time is negligible(turn-on is dominated by LS+LD)				

Notes:

- ① Repetitive Rating: Pulse width limited by maximum junction temperature.
- ② Surface Mounted on FR4 Board, t ≤ 10 sec.
- ③ Pulse Test: Pulse Width ≤ 300μs, Duty Cycle ≤ 2%.
- ④ Guaranteed by design, not subject to production
- ⑤ EAS condition: T_J=25°C,V_{DD}=-10V,V_G=-10V,L=0.5mH,R_g=25Ω

Typical Electrical and Thermal Characteristics

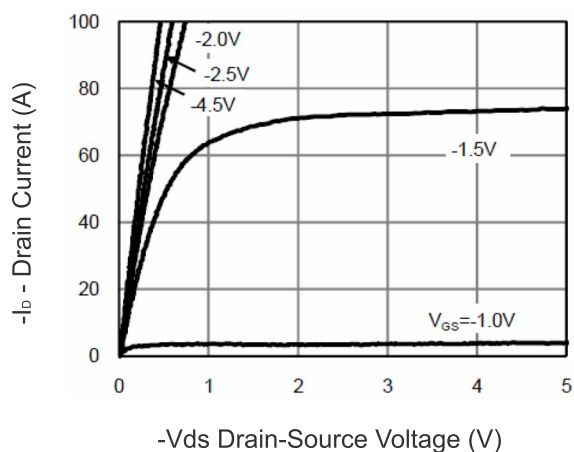


Figure 1 Output Characteristics

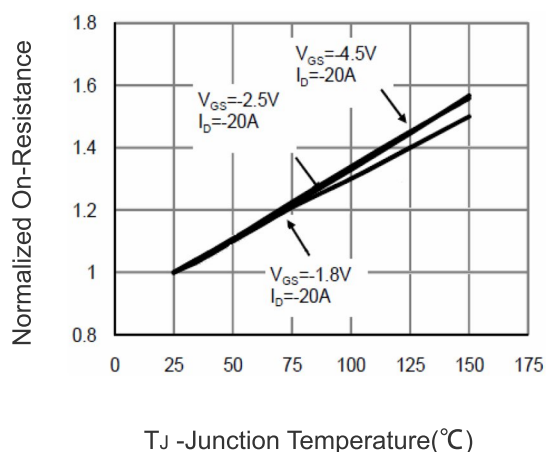


Figure 4 $R_{DS(on)}$ -Junction Temperature

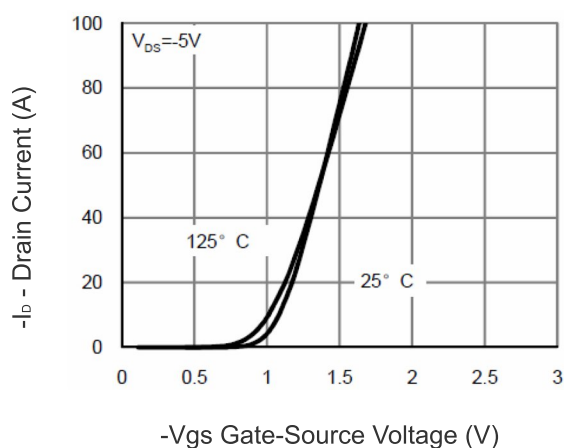


Figure 2 Transfer Characteristics

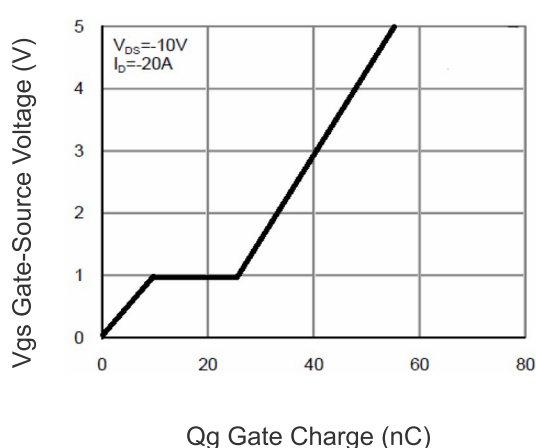


Figure 5 Gate Charge

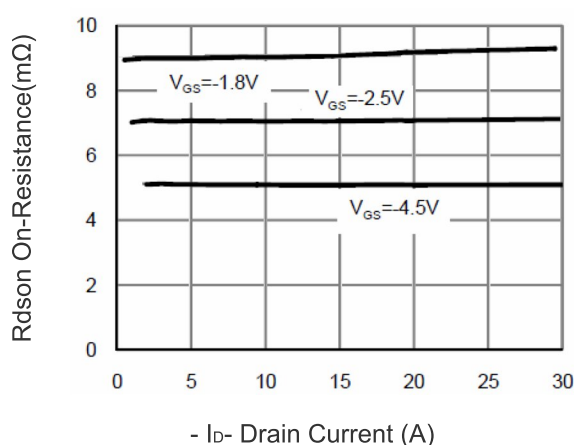


Figure 3 $R_{DS(on)}$ - Drain Current

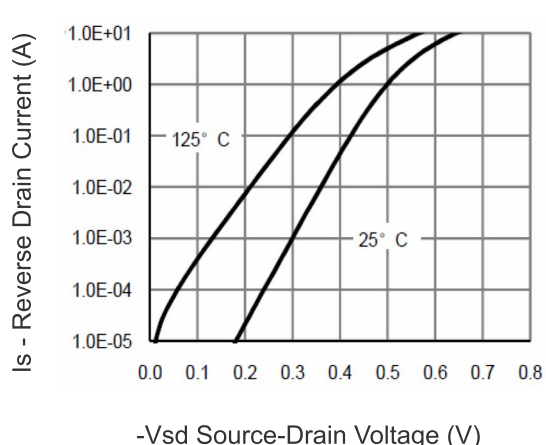
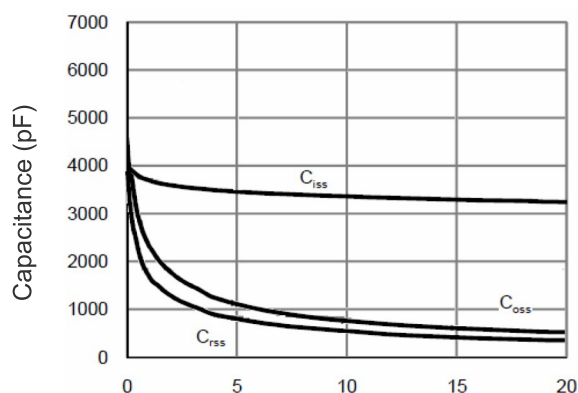
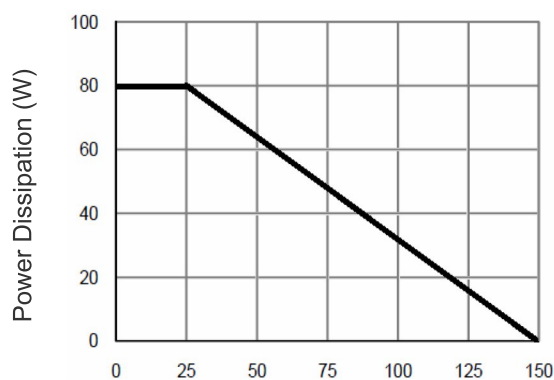


Figure 6 Drain-Source On-Resistance



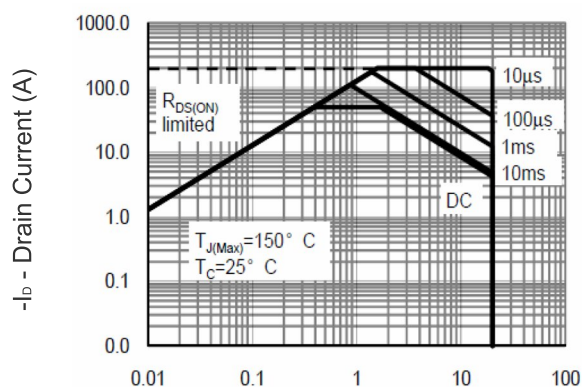
-Vds Drain-Source Voltage (V)

Figure 7 Capacitance vs Vds



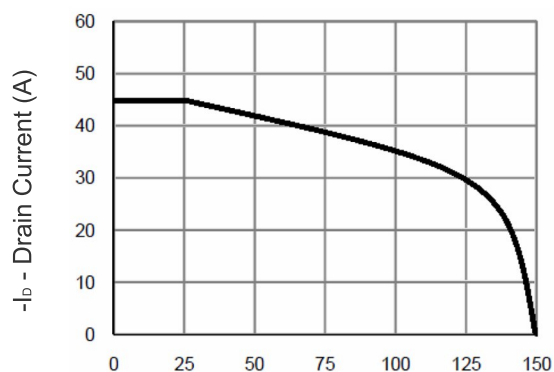
T_J - Junction Temperature(°C)

Figure 9 Power De-rating



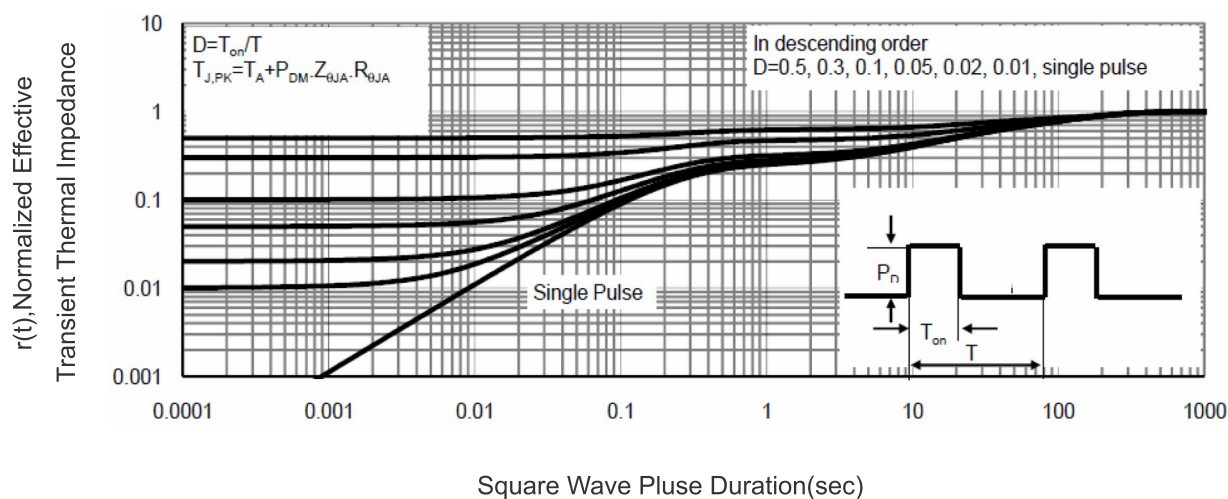
-Vds Drain-Source Voltage (V)

Figure 8 Safe Operation Area



T_J - Junction Temperature(°C)

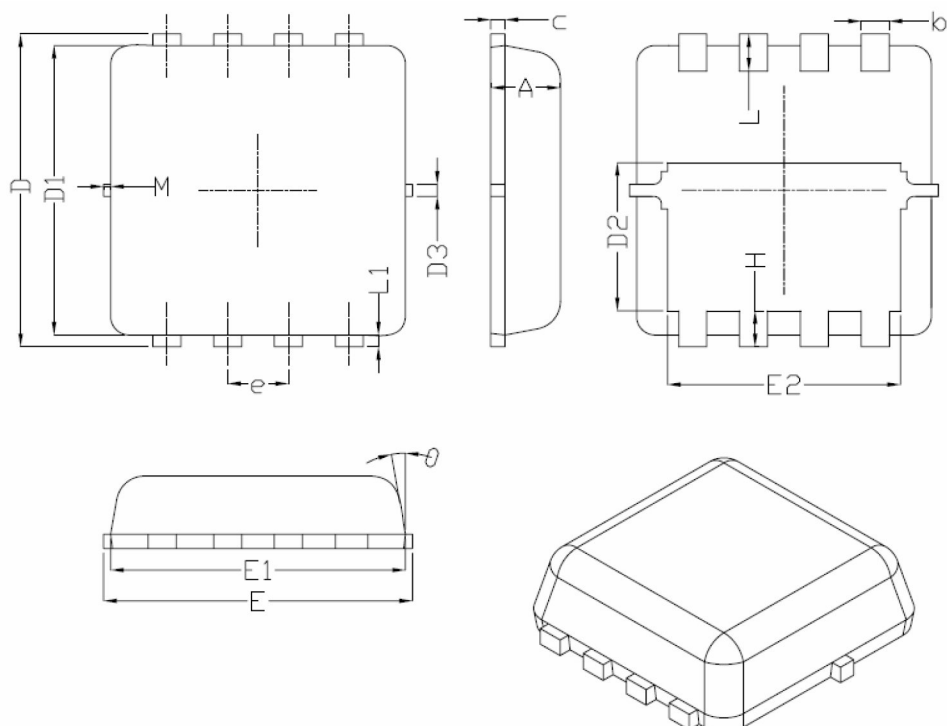
Figure 10 -Current De-rating



Square Wave Pluse Duration(sec)

Figure 11 Normalized Maximum Transient Thermal Impedance

DFN3.3X3.3 EP Package Information



SYMBOL	DIMENSIONAL REQMTS		
	MIN	NOM	MAX
A	0.70	0.75	0.80
b	0.25	0.30	0.35
c	0.10	0.15	0.25
D	3.25	3.35	3.45
D1	3.00	3.10	3.20
D2	1.48	1.58	1.68
D3	---	0.13	---
E	3.20	3.30	3.40
E1	3.00	3.15	3.20
E2	2.39	2.49	2.59
e	0.65BSC		
H	0.30	0.39	0.50
L	0.30	0.40	0.50
L1	---	0.13	---
θ	---	10°	12°
M	*	*	0.15
* Not specified			

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